

Search Notes

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Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

FREDRICKSON ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
347	22,20,24 29,32,33 35,34,37	6/7/2005	SWH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR